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Attorney Docket: 420/50547
PATENT

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant: THOMAS BECKER ET AL
Serial No.: 09/980,122
Filed: NOVEMBER 30, 2001
Title: SEMICONDUCTOR GAS SENSOR, GAS SENSOR SYSTEM
AND METHOD OF GAS ANALYSIS

**INFORMATION DISCLOSURE STATEMENT
UNDER 37 CFR §§ 1.97 and 1.98**

Commissioner for Patents
Washington, D.C. 20231

Sir:

In accordance with the duty of disclosure under 37 CFR §1.56, Applicant hereby notifies the U.S. Patent and Trademark Office of the documents which are listed on the attached Form PTO-1449 and/or listed herein and which the Examiner may deem relevant to patentability of the claims of the above-identified application.

**CONCISE EXPLANATION OF NON-ENGLISH LANGUAGE
DOCUMENTS**

English abstracts summarizing the disclosures of documents AK, AN, and AO are submitted herewith.

In compliance with the concise explanation requirement under 37 CFR §1.98(a)(3) for foreign language documents, Applicant encloses herewith a copy of a corresponding foreign Search Report citing such documents, together with an

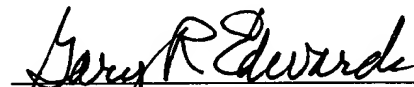
English-language version of that portion of the Search Report indicating the degree of relevance found by the foreign office.

The present Information Disclosure Statement is being filed before the mailing date of the first Office Action on the merits, and therefore no certification under 37 C.F.R. §1.97(e) or fee under 37 C.F.R. §1.17(p) is required.

The submission of the listed documents is not intended as an admission that any such document constitutes prior art against the claims of the present application. Applicant does not waive any right to take any action that would be appropriate to antedate or otherwise remove any listed document as a competent reference against the claims of the present application.

Respectfully submitted,

April 5, 2002



Gary R. Edwards

Registration No. 31,824

CROWELL & MORING, LLP
P.O. Box 14300
Washington, DC 20044-4300
Telephone No.: (202) 624-2500
Facsimile No.: (202) 628-8844

GRE/ajf